

## **Features**

- Optimized for Logic Level Drive
- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified \*

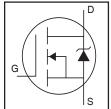
## **Description**

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

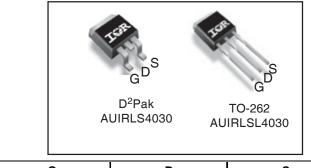
# AUIRLS4030 AUIRLSL4030

PD - 96406B

**HEXFET® Power MOSFET** 



V <sub>DSS</sub>		100V
R <sub>DS(on)</sub>	typ.	3.4m $Ω$
	max.	4.3m $Ω$
I <sub>D</sub>		180A



G	D	S
Gate	Drain	Source

# **Absolute Maximum Ratings**

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T<sub>A</sub>) is 25°C, unless otherwise specified.

	Parameter	Max.	Units
$I_D @ T_C = 25^{\circ}C$	Continuous Drain Current, V <sub>GS</sub> @ 10V	180	
$I_D @ T_C = 100^{\circ}C$	Continuous Drain Current, V <sub>GS</sub> @ 10V	130	A
I <sub>DM</sub>	Pulsed Drain Current ①	730	
$P_{D} @ T_{C} = 25^{\circ}C$	Maximum Power Dissipation	370	W
	Linear Derating Factor	2.5	W/°C
$V_{GS}$	Gate-to-Source Voltage	± 16	V
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally limited) ②	305	mJ
I <sub>AR</sub>	Avalanche Current ①	See Fig. 14, 15, 22a, 22b,	Α
E <sub>AR</sub>	Repetitive Avalanche Energy ①		mJ
dv/dt	Peak Diode Recovery ③	21	V/ns
$T_{J}$	Operating Junction and	-55 to + 175	
T <sub>STG</sub>	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds	300	
	(1.6mm from case)		

## **Thermal Resistance**

	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case ⑦⑨		0.40	°C/W
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount), D2Pak ®		40	

HEXFET® is a registered trademark of International Rectifier.

<sup>\*</sup>Qualification standards can be found at http://www.irf.com/



## Static Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	100			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.10		V/°C	Reference to 25°C, I <sub>D</sub> = 5mA <sup>①</sup>
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance		3.4	4.3	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 110A ⊕
			3.6	4.5		$V_{GS} = 4.5V, I_D = 92A$ @
$V_{GS(th)}$	Gate Threshold Voltage	1.0		2.5	V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$
gfs	Forward Transconductance	320			S	$V_{DS} = 25V, I_{D} = 110A$
I <sub>DSS</sub>	Drain-to-Source Leakage Current			20		$V_{DS} = 100V, V_{GS} = 0V$
				250	μΑ	$V_{DS} = 100V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
I <sub>GSS</sub>	Gate-to-Source Forward Leakage			100	<b></b> Λ	V <sub>GS</sub> = 16V
	Gate-to-Source Reverse Leakage			-100	nA	$V_{GS} = -16V$
R <sub>G(int)</sub>	Internal Gate Resistance		2.1		Ω	

# Dynamic Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$Q_g$	Total Gate Charge		87	130		I <sub>D</sub> = 110A
$Q_{gs}$	Gate-to-Source Charge		27		~C	$V_{DS} = 50V$
$Q_{gd}$	Gate-to-Drain ("Miller") Charge		45		nC	V <sub>GS</sub> = 4.5V ④
Q <sub>sync</sub>	Total Gate Charge Sync. (Q <sub>g</sub> - Q <sub>gd</sub> )		42			$I_D = 110A, V_{DS} = 0V, V_{GS} = 4.5V$
t <sub>d(on)</sub>	Turn-On Delay Time		74			$V_{DD} = 65V$
t <sub>r</sub>	Rise Time		330			I <sub>D</sub> = 110A
t <sub>d(off)</sub>	Turn-Off Delay Time		110		ns	$R_G = 2.7\Omega$
t <sub>f</sub>	Fall Time		170			V <sub>GS</sub> = 4.5V ④
C <sub>iss</sub>	Input Capacitance		11360			$V_{GS} = 0V$
C <sub>oss</sub>	Output Capacitance		670			$V_{DS} = 50V$
C <sub>rss</sub>	Reverse Transfer Capacitance		290		рF	f = 1.0MHz
C <sub>oss</sub> eff. (ER)	Effective Output Capacitance (Energy Related)		760			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V $
C <sub>oss</sub> eff. (TR)	Effective Output Capacitance (Time Related)		1140			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 80V $

## **Diode Characteristics**

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current			180		MOSFET symbol
	(Body Diode)			160	A	showing the
I <sub>SM</sub>	Pulsed Source Current			730	] ^	integral reverse
	(Body Diode) ①			730		p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 110A, V_{GS} = 0V \oplus$
t <sub>rr</sub>	Reverse Recovery Time		50		no	$T_J = 25^{\circ}C$ $V_R = 85V$ ,
			60			$T_J = 125^{\circ}C$ $I_F = 110A$
$Q_{rr}$	Reverse Recovery Charge		88			$T_J = 25^{\circ}C$ di/dt = 100A/ $\mu$ s @
			130			$T_J = 125^{\circ}C$
I <sub>RRM</sub>	Reverse Recovery Current		3.3		Α	$T_J = 25^{\circ}C$
t <sub>on</sub>	Forward Turn-On Time	Intrins	ic turn-	on time	is negl	igible (turn-on is dominated by LS+LD)

#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by  $T_{Jmax}$ , starting  $T_J=25^{\circ}C$ , L=0.05mH,  $R_G=25\Omega$ ,  $I_{AS}=110A$ ,  $V_{GS}=10V$ . Part not recommended for use above this value .
- $\label{eq:local_special} \ensuremath{\Im} \ I_{SD} \leq 110A, \ di/dt \leq 1330A/\mu s, \ V_{DD} \leq V_{(BR)DSS}, \ T_J \leq 175^{\circ}C.$
- 4 Pulse width  $\leq 400 \mu s$ ; duty cycle  $\leq 2\%$ .

- $\ \ \, \ \, \ \,$   $\ \ \,$   $C_{oss}$  eff. (TR) is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$
- $\ \ \,$  C  $_{OSS}$  eff. (ER) is a fixed capacitance that gives the same energy as C  $_{OSS}$  while V  $_{DS}$  is rising from 0 to 80% V  $_{DSS}.$
- $\ensuremath{\mathfrak{D}}$   $R_\theta$  is measured at  $T_J$  approximately 90°C.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniquea refer to application note # AN- 994 echniques refer to application note #AN-994.
- $\ \ \, \ \, \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \ \,$   $\ \$   $\ \$   $\ \$   $\ \ \,$   $\ \$   $\$   $\ \$   $\ \$   $\ \$   $\$   $\ \$   $\$   $\ \$   $\ \$   $\ \$   $\$   $\ \$   $\$   $\ \$   $\$   $\ \$   $\$   $\ \$   $\$   $\ \$   $\$   $\$   $\$   $\$   $\ \$   $\$

# **Qualification Information**<sup>†</sup>

			Automotive		
		(per AEC-Q101) <sup>††</sup>			
Qualification Level		Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.			
Maiatura Canaitivity Laval		3L-D2 PAK	MSL1		
Worsture Sensit	Moisture Sensitivity Level		N/A		
	Machine Model	Class M4(+/- 800V ) <sup>†††</sup>			
	Wachine Woder	(per AEC-Q101-002)			
500	Llows and Darky Mandal	Class H3A(+/- 6000V ) <sup>†††</sup>			
ESD	ESD Human Body Model		(per AEC-Q101-001)		
St. 15 : M 11		Class C5(+/- 2000V ) <sup>†††</sup>			
Charged Device Model		(per AEC-Q101-005)			
RoHS Compliar	RoHS Compliant		Yes		

<sup>†</sup> Qualification standards can be found at International Rectifier's web site: http://www.irf.com/

<sup>††</sup> Exceptions (if any) to AEC-Q101 requirements are noted in the qualification report.

<sup>†††</sup> Highest passing voltage

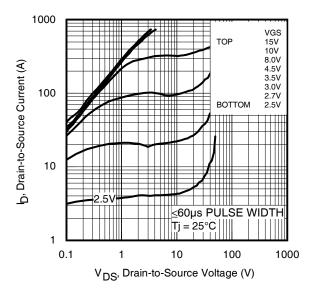


Fig 1. Typical Output Characteristics

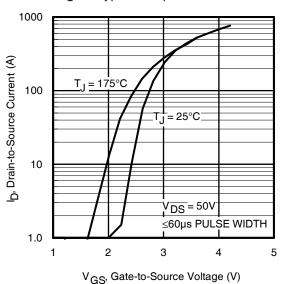


Fig 3. Typical Transfer Characteristics

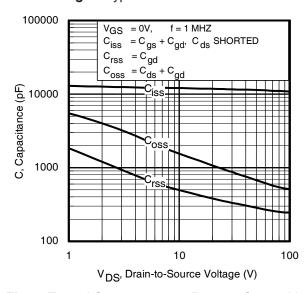


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

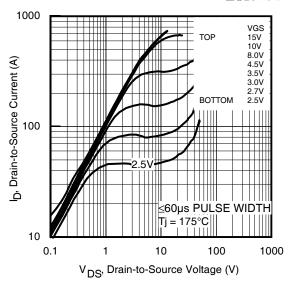


Fig 2. Typical Output Characteristics

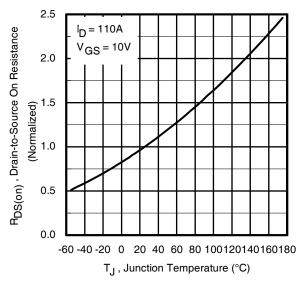
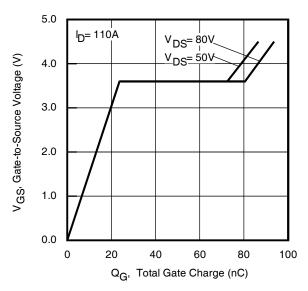
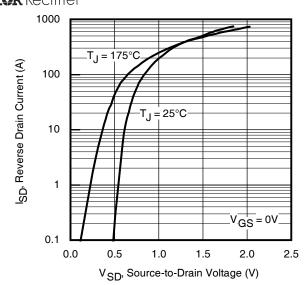


Fig 4. Normalized On-Resistance vs. Temperature



**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage www.irf.com



**Fig 7.** Typical Source-Drain Diode Forward Voltage

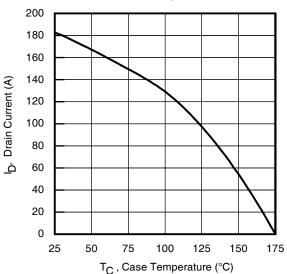
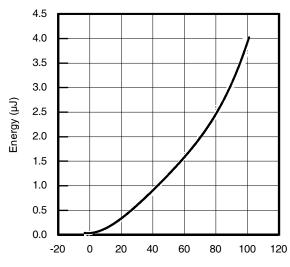


Fig 9. Maximum Drain Current vs.
Case Temperature



V<sub>DS,</sub> Drain-to-Source Voltage (V) **Fig 11.** Typical C<sub>OSS</sub> Stored Energy

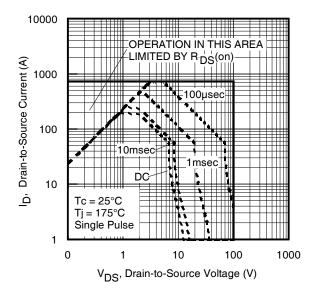


Fig 8. Maximum Safe Operating Area

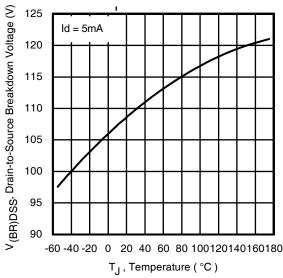


Fig 10. Drain-to-Source Breakdown Voltage

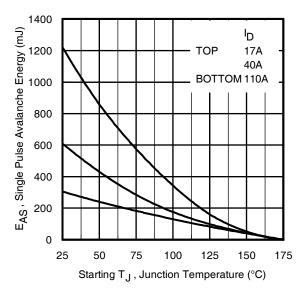


Fig 12. Maximum Avalanche Energy vs. DrainCurrent

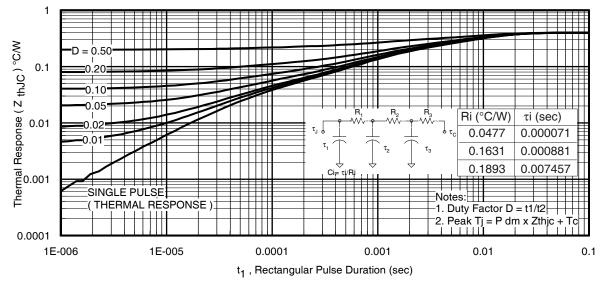


Fig 13. Maximum Effective Transient Thermal Impedance, Junction-to-Case

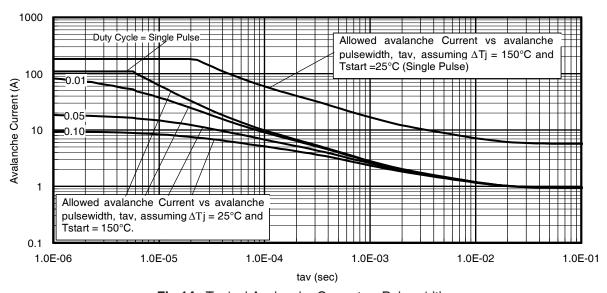


Fig 14. Typical Avalanche Current vs. Pulsewidth

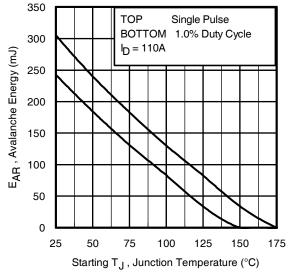


Fig 15. Maximum Avalanche Energy vs. Temperature

# Notes on Repetitive Avalanche Curves , Figures 14, 15: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption:
- Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long  $asT_{jmax}$  is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 22a, 22b.
- 4.  $P_{D (ave)}$  = Average power dissipation per single avalanche pulse.
- BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I<sub>av</sub> = Allowable avalanche current.
- 7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 14, 15).

t<sub>av =</sub> Average time in avalanche.

D = Duty cycle in avalanche =  $t_{av} \cdot f$ 

 $Z_{th,JC}(D, t_{av})$  = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \text{ (ave)}} &= 1/2 \text{ ( } 1.3 \cdot \text{BV} \cdot \text{I}_{av} \text{)} = \triangle \text{T/ } Z_{thJC} \\ I_{av} &= 2\triangle \text{T/ [ } 1.3 \cdot \text{BV} \cdot Z_{th} \text{]} \\ E_{AS \text{ (AR)}} &= P_{D \text{ (ave)}} \cdot t_{av} \end{split}$$

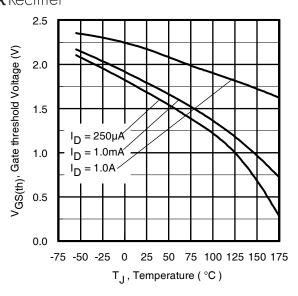


Fig 16. Threshold Voltage vs. Temperature

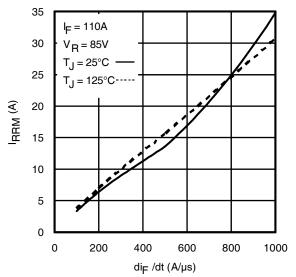


Fig. 18 - Typical Recovery Current vs. dif/dt

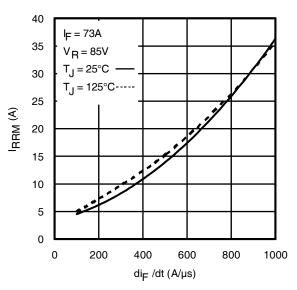


Fig. 17 - Typical Recovery Current vs. di<sub>f</sub>/dt

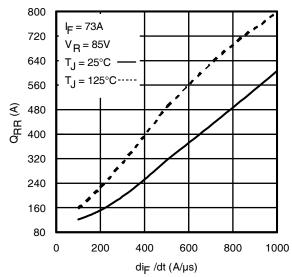


Fig. 19 - Typical Stored Charge vs. dif/dt

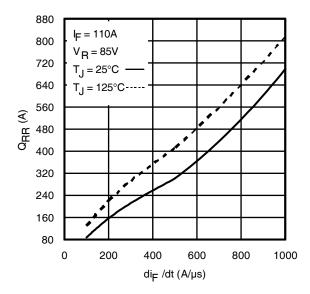


Fig. 20 - Typical Stored Charge vs. dif/dt

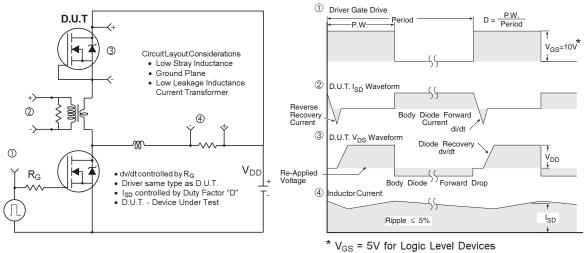


Fig 21. Peak Diode Recovery dv/dt Test Circuit for N-Channel

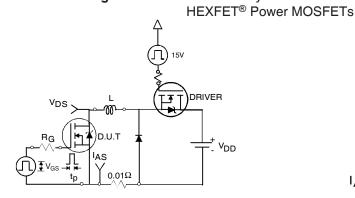


Fig 22a. Unclamped Inductive Test Circuit

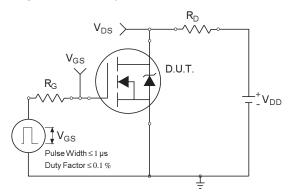


Fig 23a. Switching Time Test Circuit

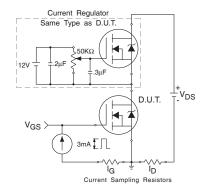


Fig 24a. Gate Charge Test Circuit

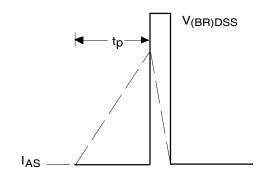


Fig 22b. Unclamped Inductive Waveforms

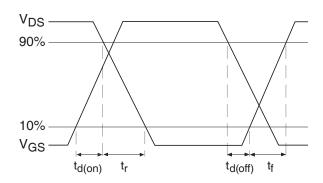


Fig 23b. Switching Time Waveforms

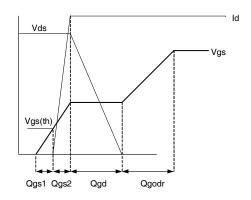
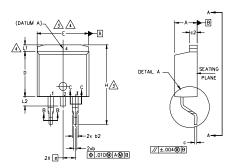
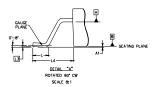


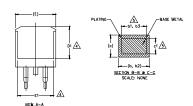
Fig 24b. Gate Charge Waveform

# $D^2 Pak \ \ Package \ \ Outline \ \ \ (\hbox{\tiny Dimensions are shown in millimeters (inches)})$









#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3\DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.
- 4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.
- 5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.
- 6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 7. CONTROLLING DIMENSION: INCH.
- 8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

S		Ņ				
M B O	MILLIM	ETERS	INC	HES	N O T	
L	MIN.	MAX.	MIN.	MAX.	Ė	
Α	4.06	4.83	.160	.190		
A1	0.00	0.254	.000	.010		
b	0.51	0.99	.020	.039		
ь1	0.51	0.89	.020	.035	5	
b2	1,14	1.78	.045	.070		
ь3	1.14	1.73	.045	.068	5	
С	0,38	0.74	.015	.029		
c1	0.38	0.58	.015	.023	5	
c2	1.14	1.65	.045	.065		
D	8.38	9.65	.330	.380	3	
D1	6.86	-	.270		4	
Ε	9.65	10.67	.380	.420	3,4	
E1	6.22	-	.245		4	
е	2.54	BSC	.100	BSC		
Н	14.61	15.88	.575	.625		
L	1.78	2.79	.070	.110		
L1	-	1.65	-	.066	4	
L2	1.27	1.78	-	.070		
L3	0.25	BSC	.010 BSC			
L4	4.78	5.28	.188	.208		

## LEAD ASSIGNMENTS

#### **HEXFET**

1.- GATE 2, 4.- DRAIN 3.- SOURCE

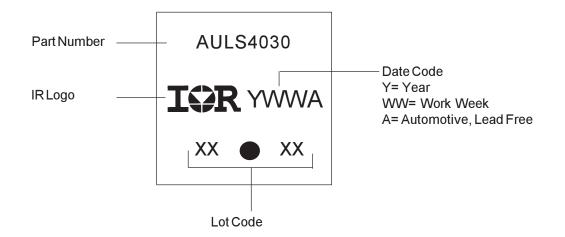
#### IGBTs, CoPACK

1.- GATE
2. 4.- COLLECTOR
3.- EMITTER

#### DIODES

- 1.- ANODE \*
  2, 4.- CATHODE
  3,- ANODE
- \* PART DEPENDENT.

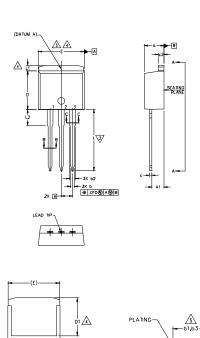
# D<sup>2</sup>Pak Part Marking Information



# TO-262 Package Outline ( Dimensions are shown in millimeters (inches))

-BASE METAL

SECTION B-B & C-C SCALE: NONE



#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

3\DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61 AND c1 APPLY TO BASE METAL ONLY.

- 6. CONTROLLING DIMENSION: INCH.
- 7.- OUTLINE CONFORM TO JEDEC TO-262 EXCEPT A1(mox.), b(min.) AND D1(min.) WHERE DIMENSIONS DERIVED THE ACTUAL PACKAGE OUTLINE.

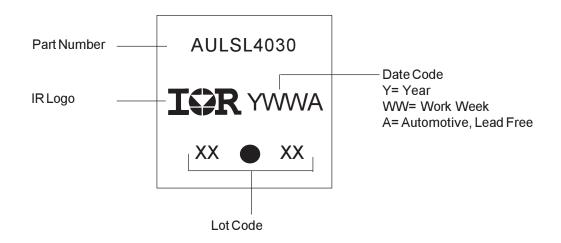
S	DIMENSIONS				
M B O L	MILLIM	ETERS	INC	HES	N O T E S
L	MIN.	MAX.	MIN.	MAX.	S
Α	4.06	4.83	.160	.190	
A1	2.03	3.02	.080	.119	
b	0.51	0.99	.020	.039	
ь1	0.51	0.89	.020	.035	5
ь2	1,14	1.78	.045	.070	
ь3	1,14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
c1	0.38	0.58	.015	.023	5
c2	1,14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6,86	-	.270	_	4
E	9.65	10.67	.380	.420	3,4
E1	6.22	-	.245		4
е	2,54	BSC	.100	BSC	
L	13.46	14,10	.530	.555	
L1	_	1.65	-	.065	4
L2	3,56	3,71	.140	.146	

# LEAD ASSIGNMENTS HEXFET 1.— GATE 2.— DRAIN 3.— SOURCE 4.— DRAIN IGBTS, COPACK 1.— GATE 2.— COLLECTOR 3.— EMITTER

4.- COLLECTOR

# TO-262 Part Marking Information

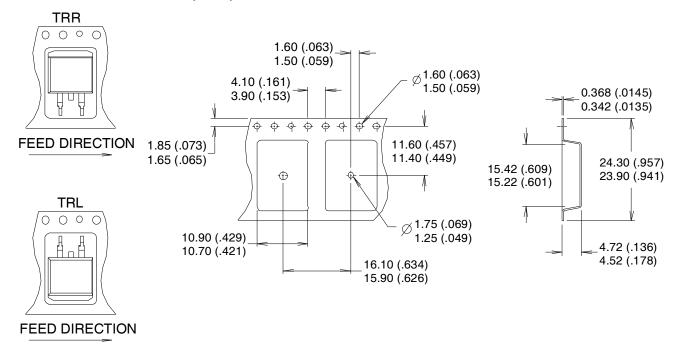
SECTION A-A

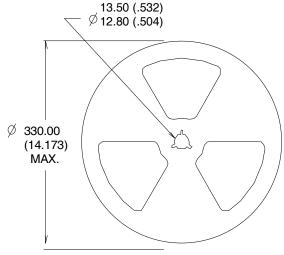


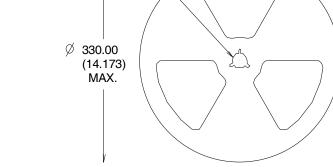
Note: For the most current drawing please refer to IR website at <a href="http://www.irf.com/package/">http://www.irf.com/package/</a>

# D<sup>2</sup>Pak (TO-263AB) Tape & Reel Information

Dimensions are shown in millimeters (inches)

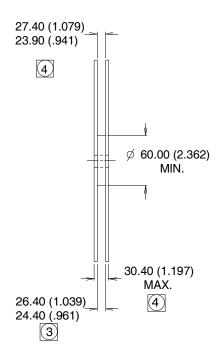






## NOTES:

- 1. COMFORMS TO EIA-418.
- 2. CONTROLLING DIMENSION: MILLIMETER.
- 3 DIMENSION MEASURED @ HUB.
- 4 INCLUDES FLANGE DISTORTION @ OUTER EDGE.



# **Ordering Information**

Base part	Package Type	Standard Pack		Complete Part Number
		Form	Quantity	
AUIRLSL4030	TO-262	Tube	50	AUIRLSL4030
AUIRLS4030	D2Pak	Tube	50	AUIRLS4030
		Tape and Reel Left	800	AUIRLS4030TRL
		Tape and Reel Right	800	AUIRLS4030TRR

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